

Amendments to the Claims:

The listing of claims will replace all prior versions, and listings, of claims in the application. Please cancel Claim 14, amend Claims 13, 15-17 and 21-23, and add new Claim 25 as follows:

Listing of Claims:

1. (Withdrawn) A plasma processing apparatus for supplying radio-frequency power into a process chamber so as to generate plasma, to thereby treat an object to be processed with the plasma;

wherein the process chamber has a top plate which is disposed opposite to the object to be processed, through the medium of a region for generating the plasma; and a radio-frequency antenna is disposed in the inside and outside of the process chamber so that the radio-frequency antenna is wound around the top plate.

2. (Withdrawn) A plasma processing apparatus according to claim 1, wherein at least one metal-based radio-frequency antenna is disposed, in the process chamber, so as to provide a linear and/or curved line.

3. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the radio-frequency antenna disposed in the process chamber is covered with an insulating material so that the radio-frequency antenna does not directly contact the plasma.

4. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the length of the radio-frequency antenna disposed in the process chamber is not smaller than $(n/2-1/4)\lambda_0$ (wherein λ_0 is the wavelength of the radio-frequency power, and n is an integer) and not larger than $(n/2+1/4)\lambda_0$.

5. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the thickness or diameter of the radio-frequency antenna disposed in the process chamber is changed along with the propagation direction of the radio-frequency power.

6. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the radio-frequency antenna is disposed in the process chamber, so that the density of the radio-frequency antenna arrangement is changed with respect to the central portion and peripheral portion of the process chamber, and/or with respect to the height direction of the process chamber.

7. (Withdrawn) A plasma processing apparatus according to claim 3, where an insulating fluid is circulated between the radio-frequency antenna disposed in the process chamber, and the insulating material.

8. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the distance between the top plate and the radio-frequency antenna disposed in the process chamber is variable.

9. (Withdrawn) A plasma processing apparatus according to claim 1, wherein a measuring device is disposed in at least one position of the top plate so as to monitor the state of the generated plasma.

10. (Withdrawn) A plasma processing apparatus according to claim 1, wherein the top plate has a plurality of apertures for passing a gas to be supplied to the process chamber.

11. (Withdrawn) A plasma processing apparatus according to claim 1, wherein a susceptor for supporting the object to be processed is disposed in the process chamber, and a bias is applied to the susceptor.

12. (Withdrawn) A plasma processing apparatus according to claim 1, wherein at least a portion of the ground line in the process chamber has an opening, and the plasma is generated due to the radiation of a microwave electric field from the opening toward the outside of the ground line.

13. (Currently Amended) A plasma processing apparatus for supplying radio-frequency power into a process chamber so as to generate plasma, to thereby treat an object to be processed with the plasma;

wherein the process chamber has a top plate which is disposed opposite to the object to be processed through the medium of a region for generating the plasma; ~~and~~ the top plate comprisesing a metal-based or silicon-based material; and

wherein a plurality of metal-based radio-frequency antennas are disposed in the process chamber, to provide linear and/or curved lines so that the directions of the respective electric currents in adjacent antennas are the same.

14. (Cancelled)

15. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~13, wherein the radio-frequency antenna disposed in the process chamber is covered with an insulating material so that the radio-frequency antenna does not directly contact the plasma.

16. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~13, wherein the length of the radio-frequency antenna disposed in the process chamber is not smaller than $(n/2-1/4)\lambda_0$ (wherein λ_0 is the wavelength of the radio-frequency power, and n is an integer) and not larger than $(n/2+1/4)\lambda_0$.

17. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~13, wherein the thickness or diameter of the radio-frequency antenna disposed in the process chamber is changed along with the propagation direction of the radio-frequency power.

18. (Withdrawn) A plasma processing apparatus according to claim 14, wherein the radio-frequency antenna is disposed, in the process chamber, so that the density of the radio-frequency antenna arrangement is changed with respect to the central portion and peripheral portion of the process chamber, and/or with respect to the height direction of the process chamber.

19. (Original) A plasma processing apparatus according to claim 15, where an insulating fluid is circulated between the radio-frequency antenna disposed in the process chamber, and the insulating material.

20. (Withdrawn) A plasma processing apparatus according to claim 14, wherein the distance between the top plate and the radio-frequency antenna disposed in the process chamber is variable.

21. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~ 13, wherein a measuring device is disposed in at least one position of the top plate so as to monitor the state of the generated plasma.

22. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~ 13, wherein the top plate has a plurality of apertures for passing a gas to be supplied to the process chamber.

23. (Currently Amended) A plasma processing apparatus according to claim ~~[[14]]~~ 13, wherein a susceptor for supporting the object to be processed is disposed in the process chamber, and a bias is applied to the susceptor.

24. (Withdrawn) A plasma processing apparatus according to claim 14, wherein at least a portion of the ground line in the process chamber has an opening, and the plasma is generated due to the radiation of a microwave electric field from the opening toward the outside of the ground line.

25. (New) A plasma processing apparatus according to claim 13, wherein induction electric fields due to respective electric currents in the plurality of antennas are strengthened by each other.